

US-31261-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

3 in 1 Card Reader

ID TECH 10721 WALKER ST CYPRESS CA 90630-4720 USA

ID TECH 10721 WALKER ST CYPRESS CA 90630-4720 USA

ID TECH TAIWAN CO LTD 16 LANE 22 GAOQING RD YANGMEI TAOYUAN HSIEN 326 TAIWAN Additional Information on page 2

Optional (Class III supplied by SELV) 7.5 - 45Vdc, 3W



Type of Customer's Testing Facility (CTF) Stage used

Additional information (if necessary may also be

A sample of the product was tested and found

As shown in the Test Report Ref. No. which forms

Model / Type Ref.

reported on page 2)

to be in conformity with

part of this Certificate

VP6300

Additionally evaluated to EN 60950-1: 2006 / A11: 2009 / A1: 2010 / A12: 2011 / A2:2013; National Differences specified in the ACB Test Report.

Additional Information on page 2

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-1(ed.2);am2 E235836-A10-CB-1 issued on 2018-02-14

This CB Test Certificate is issued by the National Certification Body

 \boxtimes

Signature:



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA For full legal entity names see www.ul.com/ncbnames

Date: 2018-02-16

Jolanta M. Wroblewska